



Hearing Aid Compatibility

FCC 47 CFR section 20.19 Test Report

CDMA Cellular Phone with Bluetooth

FCC ID: OVF-K5501

Model: **K55-01**

STATEMENT OF CERTIFICATION

The data, data evaluation and equipment configuration represented herein are a true and accurate representation of the measurements of the sample's HAC RF emissions characteristics as of the dates and at the times of the test under the conditions herein specified.

STATEMENT OF COMPLIANCE

This product was tested in accordance with the measurement procedures specified in ANSI C63.19-2007 and has been shown to be capable of compliance with the technical requirements of FCC 47 CFR section 20.19.

Test performed by:	Kyocera Communications, Inc. 10300 Campus Point Drive, San Diego, CA 92121 USA	Date of Test:	10/04/10
Report Prepared by:	Thuy To Senior Regulatory Engineer	Date of Report:	10/06/10
Report Reviewed by:	C. K. Li Director of Regulatory Engineering	Date of Review:	10/12/10

HAC RF Report Page 1 of 21 Model: K55-01





TABLE OF CONTENTS

1	Introduction	3
2	Equipment Under Test (EUT)	3
3	Summary of Test Results	3
4	Test conditions	4 4 4
5		
	5.1 Test Equipment Used	6 6
6	System Validation	8
7	7.1 Test Positions 7.2 RF Emission Measurements Reference and Plane 7.3 RF Emissions Measurement Procedures 7.4 Probe Modulation Factor (PMF) 7.4.1 Measurement Procedures 7.4.2 PMF Test Results 7.4.3 PMF Peak Power Measurement Plots	9 10 11 11
8		
9	Measurement Uncertainty	15
10	0 RF Emissions Tests	16 17 18
11	1 Appendix A: Probe Calibration Certification	19
12	2 Appendix B: System Validation Plots	21
13	3 Appendix C: Test Results/Plots	21
14	4 Appendix D: Photo Test Setup	21



1 Introduction

This test report describes the Hearing Aid Compatibility (HAC) measurement of a wireless portable device manufactured by Kyocera Wireless Corp. (KWC). These measurements were performed for compliance with the rules and regulations of the U.S. Federal Communications Commission (FCC). The testing was performed in accordance with ANSI C63.19-2007.

This report covers test and data on:

X	RF Emissions	ANSI C63.19 Clause 4
	T-Coil	ANSI C63.19 Clause 6

2 Equipment Under Test (EUT)

Product:	CDMA Cellular Phone with Bluetooth	
FCC ID:	OVF-K5501	
Model Number:	K55-01	
EUT Serial Number:	IVQ80909M00124	
Type:	[] Prototype, [X] Pre-Production, [] Production	
Device Category:	Portable	
RF Exposure Environment: General Population / Uncontrolled		
Antenna:	Internal Antenna	
Detachable Antenna:	No	
External Input:	Audio/Digital Data	
Quantity:	Quantity production is planned	
Modes:	1900 CDMA	
Multiple Access Scheme: CDMA		
TX Frequency (MHz):	1850 - 1910	

3 Summary of Test Results

ANSI C63.19 (2007)		
Section 4 RF Emissions		
Test	Test Results	Overall Category
E-Field Emissions	M4	M4
H-Field Emissions	M4	1414

HAC RF Report Page 3 of 21 Model: K55-01



4 Test conditions

4.1 Ambient Conditions

All tests were performed under the following environmental conditions:

Ambient Temperature:	23 ± 2 Degrees C	
Tissue simulating liquid temperature:	22 ± 1 Degrees C	
Relative Humidity (RH):	0% <rh 80%<="" <="" th=""></rh>	
Atmospheric Pressure:	101.3kPa + 10 to -5kPa	

4.2 RF characteristics of the test site

All HAC measurements were performed inside a shielded room that provide isolation from external EM fields, with the RF ambient at least 20 dB below the intended measurement limits.

4.3 Test Signal, Frequencies and Output Power

Peak and Average conducted power were measured for each mode for comparison. RC3 SO55 was chosen for worst-case power configuration.

ONFIGURATION	CONDUCTED POWER (dBm) CDMA 1900 Ch 600	
	Average	
SO2, RC1 Full Rate	24.04	
SO2, RC3 Full Rate	23.86	
SO55, RC1 Full Rate	24.05	
SO55, RC3 Full Rate	24.37	
TDSO SO32, RC3 (FCH +SCH) Full Rate	24.27	
TDSO SO32, RC3 (-SCH) Full Rate	23.93	

HAC RF Report Page 4 of 21 Model: K55-01



During tests, the EUT was put in in-call mode and controlled by a CDMA simulator to generate the required signal and power using the configuration below.

Protocol:	6 (IS-2000)
Radio Configuration:	3
Power Control:	All Up Bits
Service Option:	55
Data Rate:	Full

In all operating modes, the phone was set to rate maximum RF power level and the measurements were performed on low, mid and high channels.

The measurement system measures power drift during HAC testing by comparing E/H-field in the same location at the beginning and at the end of measurement. These records were used to monitor stability of power output during tests. Conducted RF power measurements were also performed before and after each HAC measurements to confirm the output power.

4.4 EUT Operating Conditions

The EUT was tested with the following configurations and conditions, if applicable:

X	Fully charged standard as supplied with the handset
X	At ear use position.
	Open and Closed Configuration
	Both retracted and extended antenna positions
Χ	Simultaneous transmission with Bluetooth transmitter ON

5 Description of the test equipment

5.1 Test Equipment Used

Below is a list of the calibrated equipment used for the measurements:

Description	Manufacturer	Model Number	Serial Number	Cal Due Date
Power Meter	Giga-tronics	8541C	1831306	07/16/10
Signal Generator	Hewlett Packard	E4421B	US38440337	07/15/11
Radio Communication Tester	Agilent	8960	GB44052789	08/17/11
Data Acquisition	Speag	DAE4	527	07/09/11
E-field Probe	Speag	ER3DV6	2341	07/12/11
H-field Probe	Speag	H3DV5	6029	07/16/12
Dipole Antenna (1880MHz)	Speag	CD1880V3	1015	03/11/11
Spectrum Analyzer	Hewlett Packard	8594E	3710A04899	06/11/11

The calibration certificates of E-field and H-field probes are attached in Appendix A.

HAC RF Report Page 5 of 21 Model: K55-01



5.2 Near Field Measurement System

The measurements were performed with Dasy4 automated near-field scanning system comprised of high precision robot, robot controller, computer, near-field probe, probe alignment sensor, non-conductive phone positioner, Test Arch and software extension. The overall expanded uncertainty (K=2) of the measurement system is $\pm 10.9\%$ and $\pm 14.7\%$ for H-field and E-field resp. The measurement uncertainty budget is given in section 6.

5.3 Isotropic E-Field Probe

Model	■ ER3DV6
Construction	 One dipole parallel, two dipoles normal to probe axis Built-in shielding against static charges PEEK enclosure material (resistant to organic solvents, e.g., glycolether)
Calibration	■ In air from 100 MHz to 3.0 GHz (absolute accuracy ± 6%; k=2)
Frequency	100MHz to 6 GHzLinearity: ± 0.2dB (100MHz to 3GHz)
Directivity	 ± 0.2 dB in air (rotation around probe axis) ± 0.4 dB in air (rotation normal to probe axis)
Dynamic Range	 2 V/m to > 1000 V/m Linearity: ± 0.2 dB
Dimensions	 Overall length: 330 mm (Tip: 16 mm) Tip diameter: 8 mm (Body: 12 mm) Distance from probe tip to dipole centers: 2.5 mm
Application	 General near-field measurements up to 6 GHz Field component measurements Fast automatic scanning in phantoms

HAC RF Report Page 6 of 21 Model: K55-01



5.4 Isotropic H-Field Probe

Model	■ H3DV6
Construction	 Three concentric loop sensors with 3.8 mm loop diameters Resistively loaded detector diodes for linear response Built-in shielding against static charges PEEK enclosure material (resistant to organic solvents, e.g., glycolether)
Frequency	 200 MHz to 3 GHz (± 6.0%, k=2); Output linearized
Directivity	± 0.25 dB (spherical isotropy error)
Dynamic Range	■ 10 mA/m to 2 A/m at 1 GHz
E-Field Interference	< 10% at 3 GHz (for plane wave)
Dimensions	Overall length: 330 mm (Tip: 40 mm)
	■ Tip diameter: 6 mm (Body: 12 mm)
	 Distance from probe tip to dipole centers: 3 mm
Application	 General magnetic near-field measurements up to 3 GHz
	Field component measurements
	Surface current measurements
	Measurements in air or liquids
	Low interaction with the measured field



6 System Validation

The manufacturer calibrates the probes annually. The HAC measurements of the device were done within 24 hours of system accuracy verification, which was done using calibration dipoles. Unmodulated continuous wave of power level of 20dBm was supplied to a dipole antenna placed under Test Arch. The measurement probes are positioned over the illuminated dipole at 10mm distance from the top surface of the dipole element to the calibration reference point of the sensor, defined by the probe manufacturer.

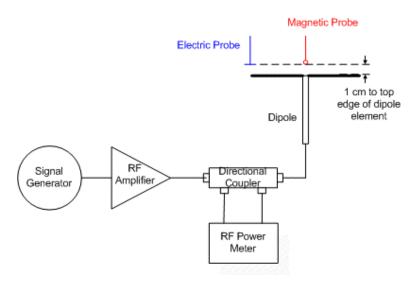


Figure 6 - System Check Setup

The length of the dipole was scanned with both E and H-field probes and the maximum values for each were recorded. The validation results are in the table below and printouts of the validation test are attached in Appendix B. All the measured parameters were within the specification.

Freq. (MHz)	Parameter	Target, SPEAG	Measured	Delta (%)	Limit (%)	Test date
1880	E dB(V/m)	140.4	136.2	-2.99	± 25	10/04/10
1000	H dB(A/m)	0.466	0.468	0.52	± 25	10/04/10

HAC RF Report Page 8 of 21 Model: K55-01



7 Description Of The Test Procedure

The device was positioned and setup according to ANSI C63.19-2007.

7.1 Test Positions

The device was placed on a non-conductive phone positioner under the Test Arch.

7.2 RF Emission Measurements Reference and Plane

Figure 7.2 illustrates the references and reference plane that shall be used in the EUT emissions measurement:

- The grid is 5 cm by 5 cm area that is divided into 9 evenly sized blocks or sub-grids.
- The grid is centered on the audio frequency output transducer (speaker) of the EUT.
- The grid is in a reference plane, which is defined as the planar area that contains the highest point in the area of the phone that normally rests against the user's ear. It is parallel to the centerline of the receiver of the EUT and is defined by the points of the receiver-end of the EUT, which, in normal handset use, rest against the ear.
- The measurement plane is parallel to, and 1.5 cm in front of, the reference plane.

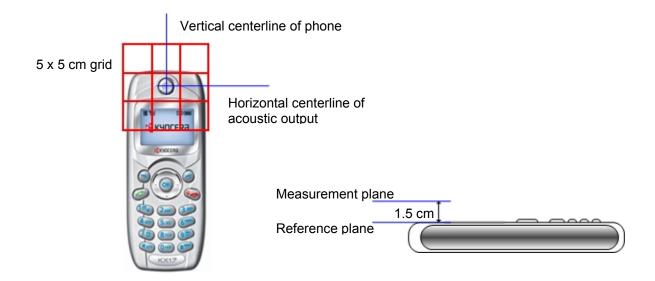


Figure 7.2 – Measurement Reference and Plane

HAC RF Report Page 9 of 21 Model: K55-01



7.3 RF Emissions Measurement Procedures

Figure 7.6 shows the near field emission measurement flowchart:

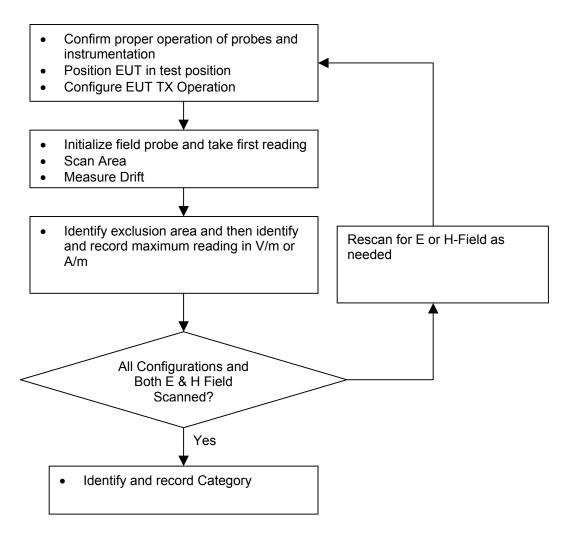


Figure 7.3 - Near field emission measurement flowchart

- 1. The center of the probe was scanning to the edges of the grid. Accordingly the total area covered by the outside edge of the probe was the 5 cm by 5 cm area, increased by half (½) the probe diameter on all sides.
- 2. The nearest point on the probe measurement element(s) was held 1.5 cm from the EUT reference plane.
- 3. The probe element is that portion of the probe that is designed to receive and sense the field being measured.
- 4. The physical body of the probe housing was not used when setting this 1.5 cm distance as this would place the sensing elements at an indeterminate distance from the reference plane.
- 5. The step size of the scan is set to 5 mm or less.
- 6. Up to three blocks were excluded for each field measurement.
 - The center block containing the EUT output was not excluded.
 - A maximum of five blocks were excluded for both E- and H-field measurements for the EUT
 output being measured. Stated differently, the center sub-grid or block and 3 other blocks were
 common to both the E- and H-field measurements for a given grid.

HAC RF Report Page 10 of 21 Model: K55-01



7.4 Probe Modulation Factor (PMF)

7.4.1 Measurement Procedures

A calibration was made of the modulation response of the probe and its instrumentation chain. This calibration was performed with the field probe, attached to its instrumentation. The response of the probe system to a CW field at the frequency of interest is compared to its response to a modulated signal with equal peak amplitude to that of a CW signal. The field level of the test signals shall be more than 10 dB above the ambient level and the noise floor of the instrumentation being used. The ratio of the CW reading to that taken with a modulated reading was applied to the DUT measurements. The measurement procedures are as following:

- 1. Fix the field probe in a set location relative to the dipole antenna, as illustrated in Figure 7.4.
- 2. Setup the wireless device (EUT) with intended signal at the intended measurement frequency.
- 3. Record the reading of the probe measurement system.
- 4. Replace the wireless device with a RF signal generator producing an unmodulated CW signal and set to the wireless device operating frequency.
- 5. Set the peak power of the unmodulated signal to equal that recorded from the wireless device
- 6. Record the reading of the probe measurement system of the unmodulated CW signal.
- 7. The ratio of probe reading (CW) in step 6 to the probe reading (EUT) in step 3 is the modulation factor.

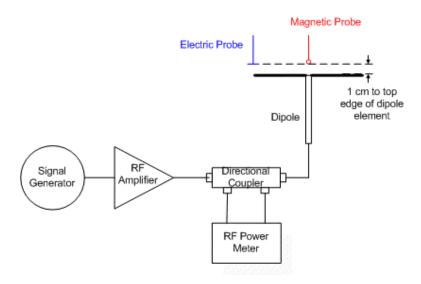


Figure 7.4 - Probe Modulation Setup

The modulation factors obtained by above method shall be applied to readings taken of the actual WD, in order to obtain an accurate peak field reading.

HAC RF Report Page 11 of 21 Model: K55-01



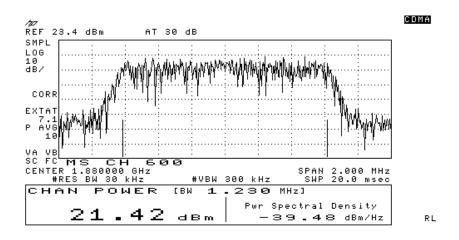


7.4.2 PMF Test Results

	E-Field							
Frequency (MHz)	Peak Power (dBm)	Protocol	Protocol Reading (V/m)	PMF Ratio	PMF (dB)			
	21.45	CW	48.41					
1880	21.42	CDMA	49.56	0.98	-0.204			
	21.44	AM	31.87	1.52	3.631			
	H-Field							
Frequency (MHz)	Peak Power (dBm)	Protocol	Protocol Reading (A/m)	PMF Ratio	PMF (dB)			
	21.36	CW	0.0398					
1880	21.39	CDMA	0.0415	0.96	-0.4			
	21.38	AM	0.0257	1.55	3.8			

7.4.3 PMF Peak Power Measurement Plots

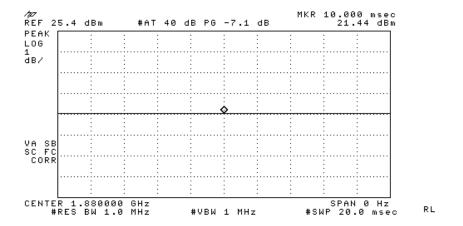
CDMA-1900



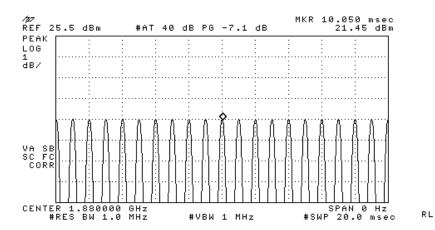




CW-1900



80%AM - 1900



HAC RF Report Page 13 of 21 Model: K55-01



8 Emission Data Extraction and Post processing

At the end of the measurements, the DASY4 system automatically evaluates the slot-averaged results, exclusion of the three highest sub-grid, application of the AWF factor per ANSI-C63.19 requirements.

The following AWF factors were used for the standard transmission protocols:

Standard	Technology	AWF
TIA/EIA/IS-2000	CDMA	0
TIA/EIA-136	TDMA (50 Hz)	0
J-STD-007	GSM (217)	-5
T1/T1P1/3GPP	UMTS (WCDMA)	0
iDEN [™]	TDMA(22 and 11 Hz)	0

Table 7.5a - Articulation Weighting Factor (AWF)

All DASY4 measurements are in RMS values. The Dasy4 system incorporates the crest factor of the signal in the computation of the RMS values. Although the software also has the capability to estimate the peak field by applying a square root of the crest factor value to the readings, the probe modulation factor was applied manually instead per ANSI C63.19 in the measurement tables in this report using equation:

Peak Field = (DASY4 reading) x PMF

where DASY4 reading = measurement from DASY4 in V/m or A/m PMF = Probe Modulation Factor in linear unit

HAC RF Report Page 14 of 21 Model: K55-01



9 Measurement Uncertainty

Table 9 shows the uncertainty budget for HAC free field assessment according to ANSI C63.19-2006. The budget is valid for the frequency range 800 MHz - 3 GHz and represents a worst-case analysis. For specific tests and configurations, the uncertainty could be smaller.

Uncertainty Description	Uncert. Value (± %)	Prob. Dist.	Div.	C _i (E)	C _i (H)	Stand. Uncert (E) (±%)	Stand. Uncert (H) (±%)
Measurement system							
Probe calibration	5.1	N	1	1	1	5.1	5.1
Axial isotropy of the probe	4.7	R	√3	1	1	2.7	2.7
Sensor displacement	16.5	R	√3	1	0.145	9.5	1.4
Boundary effects	2.4	R	√3	1	1	1.4	1.4
Probe linearity	4.7	R	√3	1	1	2.7	2.7
Scaling to Peak Envelope Power	Scaling to Peak Envelope Power 2.0 R $\sqrt{3}$ 1 1				1	1.2	1.2
System Detection limit	1.0	R	√3	1	1	0.6	0.6
Readout electronics	0.3	N	1	1	1	0.3	0.3
Response time	0.8	R	√3	1	1	0.5	0.5
Integration time	2.6	R	√3	1	1	1.5	1.5
RF ambient conditions	3.0	R	√3	1	1	1.7	1.7
RF Reflections	12	R	√3	1	1	6.9	6.9
Probe Positioner	1.2	R	√3	1	0.67	0.7	0.5
Probe positioning	4.7	R	√3	1	0.67	2.7	1.8
Extrap. and integration	Extrap. and integration 1.0 R $\sqrt{3}$ 1 1			1	0.6	0.6	
Test Sample Related							
Device positioning vertical	4.7	R	√3	1	0.67	2.7	1.8
Device Positioning Lateral	1.0	R	√3	1	1	0.6	0.6
Device Holder and Phantom	2.4	R	√3	1	1	1.4	1.4
Power drift	5.0	R	√3	1	1	2.9	2.9
Phantom and Setup Related							
Phantom thickness 2.4 R $\sqrt{3}$ 1 0.67						1.4	0.9
	Combined Standard Uncertainty:						10.9
Exten	ded Standa	ard Unce	rtainty	on Powe	er (k=2):	29.4	21.8
Exte	14.7	10.9					

N: Normal R: Rectangular

Table 9 - Worst-Case uncertainty budget for HAC free field assessment

HAC RF Report Page 15 of 21 Model: K55-01



10 RF Emissions Tests

10.1 Emission Limits

Table 10.1 shows the M-rating criteria from ANSI C63.19. All digital transmission modes in all frequency bands contained in a HAC phone must meet M3 or M4 levels.

Near	Wireless Device RF Parameters					
Field		[AWF = 0]				
Catagory	Cotomorus E-Field Er		H-Field Emissions			
Category	dB(V/m) Peak	V/m Peak	dB(A/m) Peak	V/m Peak		
Freq < 960 MHz						
M1	56.0 to 61.0	631.0 to 1122.0	5.6 to 10.6	1.91 to 3.39		
M2	51.0 to 56.0	354.8 to 631.0	0.6 to 5.6	1.07 to 1.91		
М3	46.0 to 51.0	199.5 to 354.8	-4.4 to 0.6	0.60 to 1.07		
M4	< 46.0	< 199.5	< -4.4	< 0.60		
Freq > 960 MHz						
M1	46.0 to 51.0	199.5 to 354.8	-4.4 to 0.6	0.60 to 1.07		
M2	41.0 to 46.0	112.2 to 199.5	-9.4 to -4.4	0.34 to 0.60		
М3	36.0 to 41.0	63.1 to 112.2	-14.4 to -9.4	0.19 to 0.34		
M4	< 36.0	< 63.1	< -14.4	< 0.19		

Table 10.1 - RF Emission Limits

HAC RF Report Page 16 of 21 Model: K55-01





10.2 CDMA 1900 Test Results

	CDMA 1900 E-Field							
Configuration: At ear position							Antenna	Internal
Ch.	Bat	tery	ВТ	Conducted Power	Dasy4 Reading	PMF	Peak Field	Category
#				dBm	V/m		V/m	M
25	Stan	dard	OFF	24.08	26.6	1.00	26.6	4
600	Stan	dard	OFF	24.37	29.2	1.00	29.2	4
1175	Stan	dard	OFF	24.22	28.7	1.00	28.7	4

Data plots are shown in Appendix C

	CDMA 1900 H-Field									
Configurat	ration: At ear position			Configuration: At ear position					Antenna	Internal
Ch.	Bat	tery	ВТ	Conducted Power	Dasy4 Reading	PMF	Peak Field	Category		
#				dBm	A/m			М		
25	Star	ndard	OFF	24.08	0.129	1.00	0.129	4		
600	Star	ndard	OFF	24.37	0.134	1.00	0.134	4		
1175	Star	ndard	OFF	24.22	0.101	1.00	0.101	4		

Data plots are shown in Appendix C





10.4 Worst-Case Configuration Evaluation

10.4.1 Peak Reading 360° Probe Rotation at Azimuth axis

The probe was rotated 360° in the worst-case configuration. The rotation was performed at the location of maximum field strength in the included blocks.

	CDMA 1900 E-Field							
Configuration: At ear position		Antenna:	Internal					
Ch.	Battery	Conducted Power	Peak Field	PMF	Peak Field	Category		
#		dBm	V/m		V/m	M		
25	Standard	24.08	32.36	1.0	32.36	4		

Data plots are shown in Appendix C

HAC RF Report Page 18 of 21 Model: K55-01



11 Appendix A: Probe Calibration Certification

Calibration Laboratory of Schmid & Partner

Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland





S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Client

Kyocera USA

Certificate No: ER3-2341 Jul10

Accreditation No.: SCS 108

CALIBRATION CERTIFICATE Object ER3DV6 - SN:2341 QA CAL-02.v5 and QA CAL-25.v2 Calibration procedure(s) Calibration procedure for E-field probes optimized for close near field evaluations in air Calibration date: July 12, 2010 This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate. All calibrations have been conducted in the closed laboratory facility; environment temperature (22 ± 3)°C and humidity < 70%, Calibration Equipment used (M&TE critical for calibration) Primary Standards ID# Cal Date (Certificate No.) Scheduled Calibration GB41293874 Power meter E4419B 1-Apr-10 (No. 217-01136) Apr-11 Power sensor E4412A MY41495277 1-Apr-10 (No. 217-01136) Apr-11 Power sensor E4412A MY41498087 1-Apr-10 (No. 217-01136) Apr-11 Reference 3 dB Attenuator SN: S5054 (3c) 30-Mar-10 (No. 217-01159) Mar-11 Reference 20 dB Attenuator 30-Mar-10 (No. 217-01161) SN: S5086 (20b) Mar-11 Reference 30 dB Attenuator 30-Mar-10 (No. 217-01160) SN: S5129 (30b) Mar-11 Reference Probe ER3DV6 SN: 2328 3-Oct-09 (No. ER3-2328_Oct09) Oct-10 DAF4 SN: 789 23-Dec-09 (No. DAE4-789_Dec09) Dec-10 Check Date (in house) Secondary Standards ID# Scheduled Check RF generator HP 8648C US3642U01700 4-Aug-99 (in house check Oct-09) In house check: Oct-11 Network Analyzer HP 8753E US37390585 18-Oct-01 (in house check Oct-09) In house check: Oct10 Namo Function Technical Manager Calibrated by: Katja Pokovic Approved by: Niels Kuster Quality Manager Issued: July 14, 2010 This calibration certificate shall not be reproduced except in full without written approval of the laboratory,

Certificate No: ER3-2341_Jul10 Page 1 of 10



Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA

Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 108

Client Kyocera USA

Certificate No: H3-6029 Jul10

client Kyocera USA			vo: H3-6029_Jul10
CALIBRATION	CERTIFICAT	TE	200
Object	H3DV5 - SN:60)29	
Calibration procedure(s)	7.07.600 pt 64.600 pt 64.000 pt 64.000	and QA CAL-25.v2 cedure for H-field probes optimize air	d for close near field
Calibration date:	July 16, 2010		
The measurements and the und	ertainties with confidence	ational standards, which realize the physical un probability are given on the following pages as tory facility: environment temperature $(22 \pm 3)^2$	nd are part of the certificate.
Calibration Equipment used (M&			
Primary Standards	ID#	Cal Date (Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	1-Apr-10 (No. 217-01136)	Apr-11
ower sensor E4412A	MY41495277	1-Apr-10 (No. 217-01136)	Apr-11
ower sensor E4412A	MY41498087	1-Apr-10 (No. 217-01136)	Apr-11
Reference 3 dB Attenuator Reference 20 dB Attenuator	SN: S5054 (3c)	30-Mar-10 (No. 217-01159)	Mar-11
Reference 30 dB Attenuator	SN: S5086 (20b) SN: S5129 (30b)	30-Mar-10 (No. 217-01161)	Mar-11
Reference Probe H3DV6	SN: 6182	30-Mar-10 (No. 217-01160) 3-Oct-09 (No. H3-6182_Oct09)	Mar-11 Oct-10
AE4	SN: 789	23-Dec-09 (No. DAE4-789_Dec09)	Dec-10
econdary Standards	ID#	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642U01700	4-Aug-99 (in house check Oct-09)	In house check: Oct-11
etwork Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-09)	In house check: Oct10
	Name	Function	Signature
alibrated by:	Jeton Kastrati	Laboratory Technician	1_ (
·			v Veze e e e e e e e e e e e e e e e e e
pproved by:	Katja Pokovic	Technical Manager	

Certificate No: H3-6029_Jul10

Page 1 of 10

HAC RF Report Page 20 of 21 Model: K55-01





12 Appendix B: System Validation Plots

(See attachment)

13 Appendix C: Test Results/Plots

(See attachment)

14 Appendix D: Photo Test Setup

(see attachment)

HAC RF Report Page 21 of 21 Model: K55-01